

Notice of References Cited	Application/Control No. 10/578,930		Applicant(s)/Patent Under Reexamination SUN ET AL.	
	Examiner KIBROM T. HAILU		Art Unit 2461	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0215611	09-2006	Nakagawa et al.	370/332
*	B	US-2004/0002334	01-2004	Lee et al.	455/436
*	C	US-6,577,671	06-2003	Vimpari, Markku	375/146
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	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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